Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,914	CHIBA ET AL.	
Examiner	Art Unit	
Falian C. Hitaaha	4700	

SEARCHED			
Class	Subclass	Date	Examiner
117	200	4/19/2005 _.	F.H.
117	206	4/19/2005	F.H.
117	900	4/19/2005	F.H.
117	914	4/19/2005	F.H.
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
NONE .	4/19/2005	F.H.
Inventors' Name Search (see attached papers)	4/19/2005	F.H.
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